

Search Notes

Application/Control No.

10/566,705

Examiner

Eunhee Kim

Applicant(s)/Patent under
Reexamination

ICHIKAWA ET AL.

Art Unit

2123

SEARCHED

Class	Subclass	Date	Examiner
703	22	12/29/2006	EHC
Above	Updated	7/5/2007	EK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Conducted inventors search	12/29/2006	EHC
East text search See attached	12/29/2006	EHC
Updated the text search	7/5/2007	EK